

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HATOH ET AL.	
		10/019,975	Examiner	Art Unit Mark Ruthkosky 1745

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
	D	US-			
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	K	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

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